

# **ZXMC3F31DN8** **30V SO8 Complementary dual enhancement mode** **MOSFET**

## **Summary**

Device	$V_{(BR)DSS}$ (V)	$Q_G$ (nC)	$R_{DS(on)}$ ( $\Omega$ )	$I_D$ (A)
Q1	30	12.9	0.024 @ $V_{GS} = 10V$	7.3
			0.039 @ $V_{GS} = 4.5V$	5.7
Q2	-30	12.7	0.045 @ $V_{GS} = -10V$	5.3
			0.080 @ $V_{GS} = -4.5V$	4



## **Description**

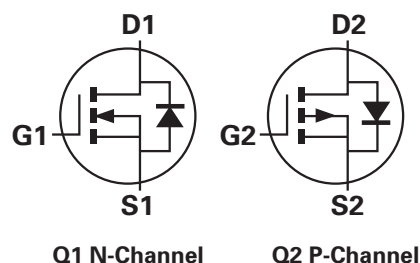
This new generation Trench MOSFET from Zetex has been designed to minimize the on-state resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance making it ideal for power management and battery charging functions.

## **Features**

- Low on-resistance
- 4.5V gate drive capability
- Low profile SOIC package

## **Applications**

- DC-DC Converters
- SMPS
- Load switching switches
- Motor control
- Backlighting

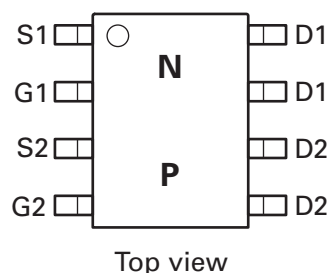


## **Ordering information**

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMC3F31DN8TA	7	12	500

## **Device marking**

ZXMC  
3F31



# ZXMC3F31DN8

## Absolute maximum ratings

Parameter	Symbol	N-channel Q1	P-channel Q2	Unit
Drain-Source voltage	$V_{DSS}$	30	-30	V
Gate-Source voltage	$V_{GS}$	$\pm 20$	$\pm 20$	V
Continuous Drain current @ $V_{GS}=10V$ ; $T_A=25^\circ C$ (b)(d) @ $V_{GS}=10V$ ; $T_A=70^\circ C$ (b)(d) @ $V_{GS}=10V$ ; $T_A=25^\circ C$ (a)(d) @ $V_{GS}=10V$ ; $T_A=25^\circ C$ (a)(e) @ $V_{GS}=10V$ ; $T_L=25^\circ C$ (f)(d)	$I_D$	7.3 5.9 5.7 6.8 7.8	5.3 4.3 4.1 4.9 5.7	A
Pulsed Drain current (c)	$I_{DM}$	33	23	A
Continuous Source current (Body diode) (b)(d)	$I_S$	3.5	3.2	A
Pulsed Source current (Body diode) (c)(d)	$I_{SM}$	33	23	A
Power dissipation at $T_A=25^\circ C$ (a)(d) Linear derating factor	$P_D$	1.25 10		W mW/°C
Power dissipation at $T_A=25^\circ C$ (a)(e) Linear derating factor	$P_D$	1.8 14		W mW/°C
Power dissipation at $T_A=25^\circ C$ (b)(d) Linear derating factor	$P_D$	2.1 17		W mW/°C
Power dissipation at $T_L=25^\circ C$ (f) (d) Linear derating factor	$P_D$	2.35 19		W mW/°C
Operating and storage temperature range	$T_j, T_{stg}$	-55 to 150		°C

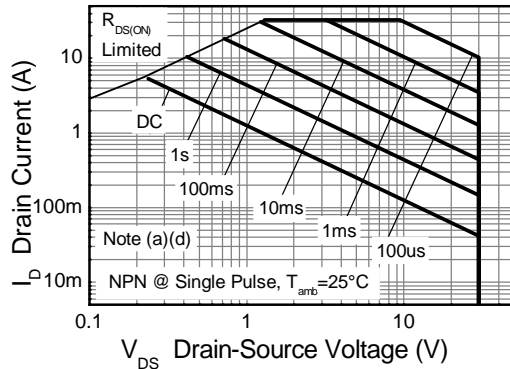
## Thermal resistance

Parameter	Symbol	Value	Unit
Junction to ambient (a)(d)	$R_{\theta JA}$	100	°C/W
Junction to ambient (a)(e)	$R_{\theta JA}$	70	°C/W
Junction to ambient (b)(d)	$R_{\theta JA}$	60	°C/W
Junction to lead (f) (d)	$R_{\theta JL}$	53	°C/W

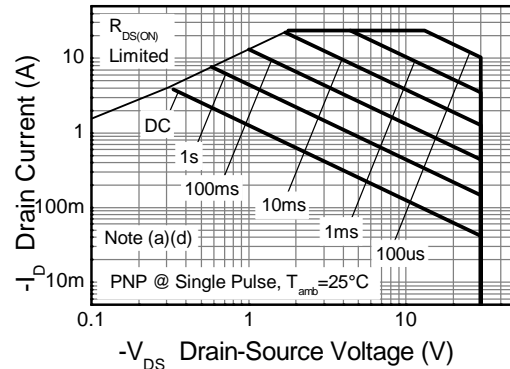
### NOTES:

- (a) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.
- (b) Mounted on FR4 PCB measured at  $t \leq 10$  sec.
- (c) Repetitive rating on 25mm x 25mm FR4 PCB,  $D=0.02$ , pulse width 300us – pulse width limited by maximum junction temperature.
- (d) For a device with one active die.
- (e) For a device with two active die running at equal power.
- (f) Thermal resistance from junction to solder-point (at the end of the drain lead).

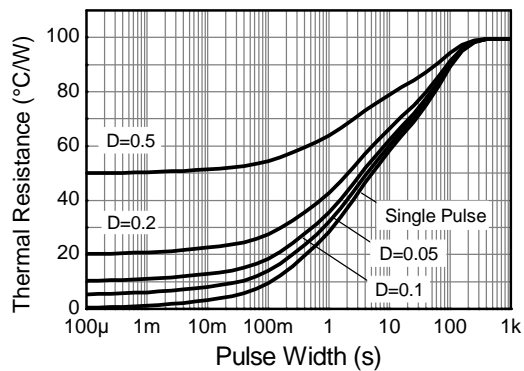
## Thermal characteristics



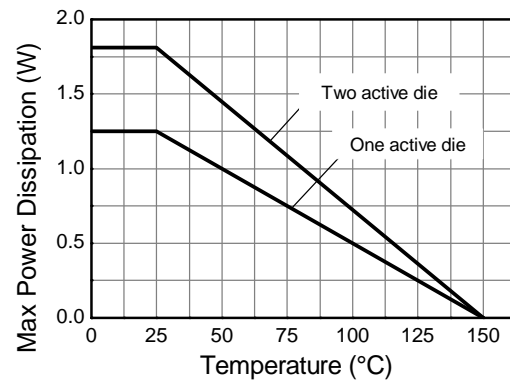
**N-channel Safe Operating Area**



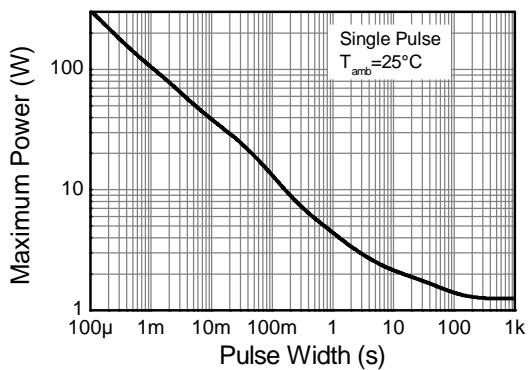
**P-channel Safe Operating Area**



**Transient Thermal Impedance**



**Derating Curve**



**Pulse Power Dissipation**

# ZXMC3F31DN8

## Q1 N-channel electrical characteristics (at $T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	V <sub>(BR)DSS</sub>	30			V	I <sub>D</sub> = 250μA, V <sub>GS</sub> =0V
Zero Gate voltage Drain current	I <sub>DSS</sub>			0.5	μA	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V
Gate-Body leakage	I <sub>GSS</sub>			100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V
Gate-Source threshold voltage	V <sub>GS(th)</sub>	1.0		3.0	V	I <sub>D</sub> = 250μA, V <sub>DS</sub> =V <sub>GS</sub>
Static Drain-Source on-state resistance (*)	R <sub>DS(on)</sub>			0.024 0.039	Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 7.0A V <sub>GS</sub> = 4.5, I <sub>D</sub> = 6.0A
Forward Transconductance (*) (†)	g <sub>fs</sub>		16.5		S	V <sub>DS</sub> = 15V, I <sub>D</sub> = 7.0A
Dynamic (†)						
Input capacitance	C <sub>iss</sub>		608		pF	V <sub>DS</sub> = 15V, V <sub>GS</sub> =0V f=1MHz
Output capacitance	C <sub>oss</sub>		132		pF	
Reverse transfer capacitance	C <sub>rss</sub>		72		pF	
Switching (‡) (†)						
Turn-on-delay time	t <sub>d(on)</sub>		2.9		ns	V <sub>DD</sub> = 15V, V <sub>GS</sub> =10V I <sub>D</sub> = 1A R <sub>G</sub> ≅ 6.0Ω,
Rise time	t <sub>r</sub>		3.3		ns	
Turn-off delay time	t <sub>d(off)</sub>		16		ns	
Fall time	t <sub>f</sub>		8		ns	
Total Gate charge	Q <sub>g</sub>		12.9		nC	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 10V I <sub>D</sub> = 7A
Gate-Source charge	Q <sub>gs</sub>		2.5		nC	
Gate-Drain charge	Q <sub>gd</sub>		2.52		nC	
Source–Drain diode						
Diode forward voltage (*)	V <sub>SD</sub>		0.82	1.2	V	I <sub>S</sub> = 1.7A,V <sub>GS</sub> =0V
Reverse recovery time (‡)	t <sub>rr</sub>		12		ns	I <sub>S</sub> = 2.2A,di/dt=100A/μs
Reverse recovery charge(‡)	Q <sub>rr</sub>		4.8		nC	

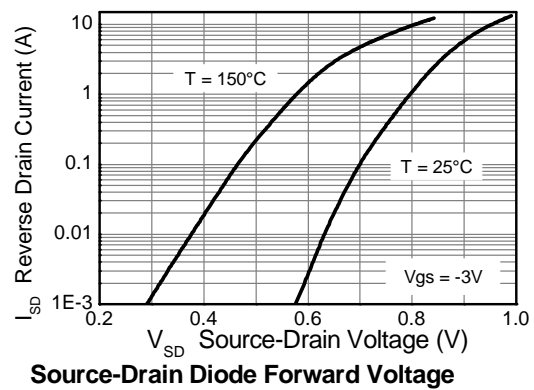
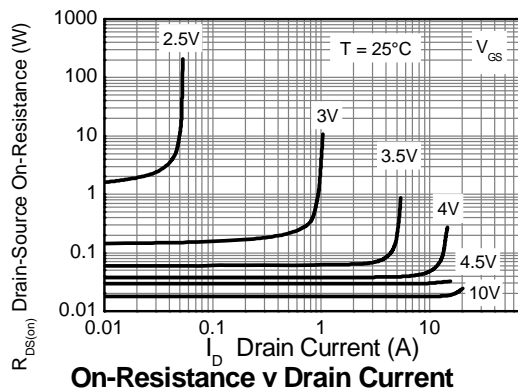
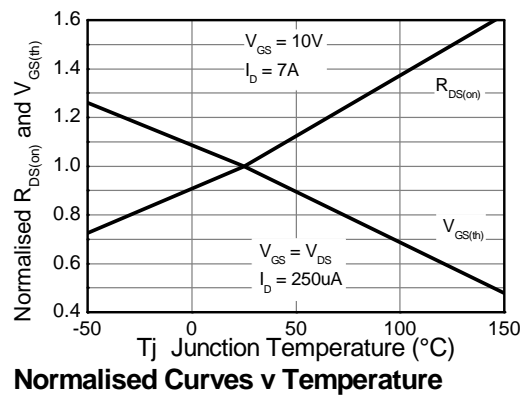
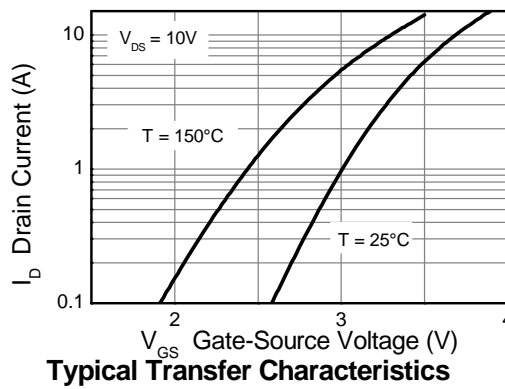
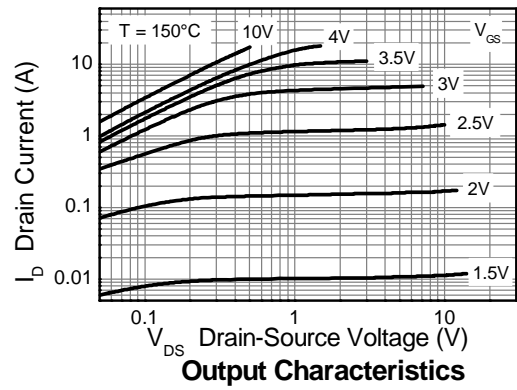
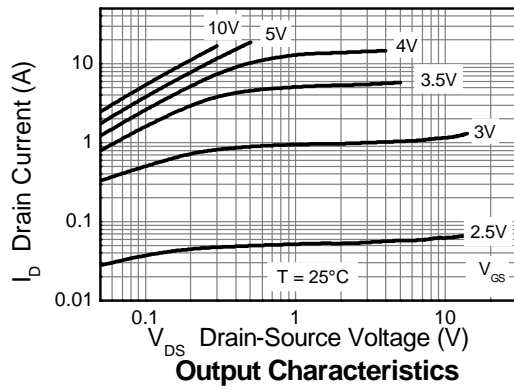
### NOTES:

(\*) Measured under pulsed conditions. Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

(†) Switching characteristics are independent of operating junction temperature.

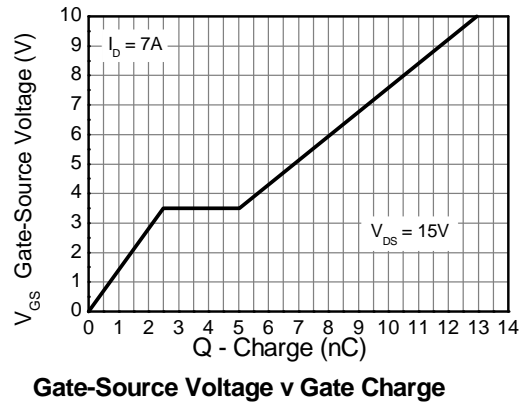
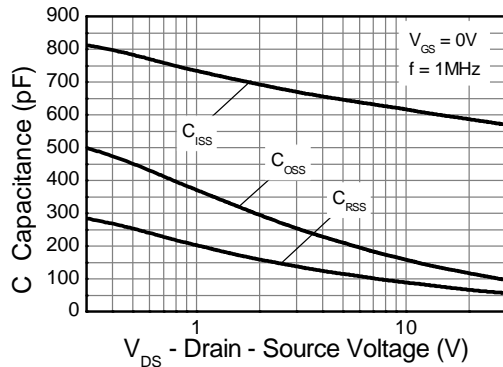
(‡) For design aid only, not subject to production testing

## Q1 Typical characteristics

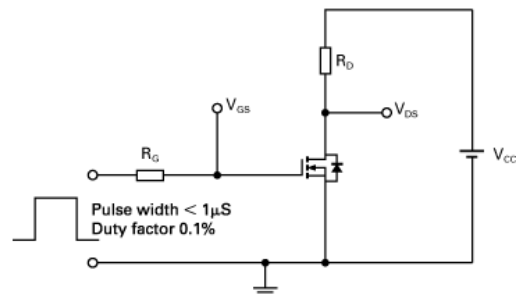
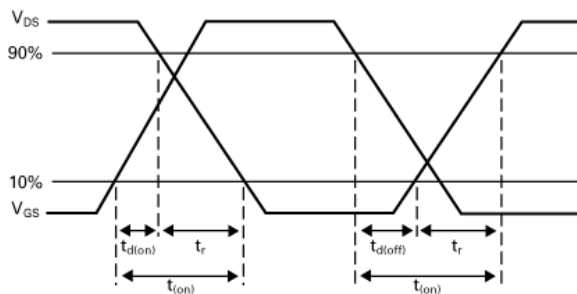
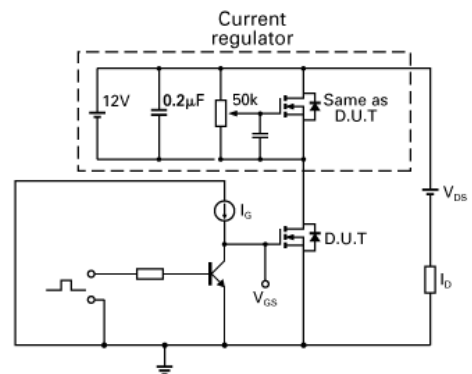
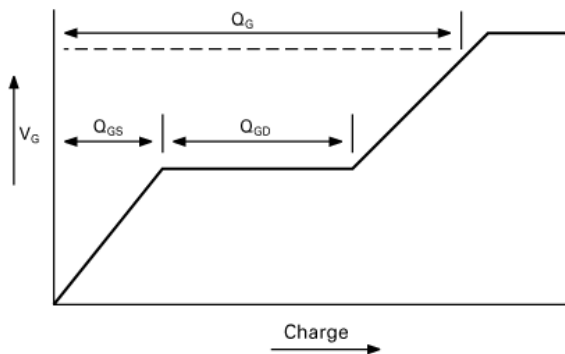


# ZXMC3F31DN8

## Q1 Typical characteristics –cntd.



## Test circuits



# ZXMC3F31DN8

## Q2 P-channel electrical characteristics (at $T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	V <sub>(BR)DSS</sub>	-30			V	I <sub>D</sub> = -250μA, V <sub>GS</sub> =0V
Zero Gate voltage Drain current	I <sub>DSS</sub>			-5.0	μA	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V
Gate-Body leakage	I <sub>GSS</sub>			-100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V
Gate-Source threshold voltage	V <sub>GS(th)</sub>	-1.0		-3.0	V	I <sub>D</sub> = -250μA, V <sub>DS</sub> =V <sub>GS</sub>
Static Drain-Source on-state resistance <sup>(*)</sup>	R <sub>DS(on)</sub>			0.045 0.080	Ω	V <sub>GS</sub> = -10V, I <sub>D</sub> = -5.0A V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -4.0A
Forward Transconductance <sup>(*)</sup> (†)	g <sub>fs</sub>		14		S	V <sub>DS</sub> = -15V, I <sub>D</sub> = -5.0A
Dynamic <sup>(†)</sup>						
Input capacitance	C <sub>iss</sub>		670		pF	V <sub>DS</sub> = -15V, V <sub>GS</sub> =0V f=1MHz
Output capacitance	C <sub>oss</sub>		126		pF	
Reverse transfer capacitance	C <sub>rss</sub>		70		pF	
Switching <sup>(‡)</sup> (†)						
Turn-on-delay time	t <sub>d(on)</sub>		1.9		ns	V <sub>DD</sub> = -15V, V <sub>GS</sub> =-10V I <sub>D</sub> = -1A R <sub>G</sub> ≅ 6.0Ω,
Rise time	t <sub>r</sub>		3		ns	
Turn-off delay time	t <sub>d(off)</sub>		30		ns	
Fall time	t <sub>f</sub>		21		ns	
Total Gate charge	Q <sub>g</sub>		12.7		nC	V <sub>DS</sub> = -15V, V <sub>GS</sub> = -10V I <sub>D</sub> = -5A
Gate-Source charge	Q <sub>gs</sub>		2		nC	
Gate-Drain charge	Q <sub>gd</sub>		2.4		nC	
Source–Drain diode						
Diode forward voltage <sup>(*)</sup>	V <sub>SD</sub>		-0.82	-1.2	V	I <sub>S</sub> = -2A,V <sub>GS</sub> =0V
Reverse recovery time <sup>(‡)</sup>	t <sub>rr</sub>		16.5		ns	I <sub>S</sub> = -2.1A,di/dt=100A/μs
Reverse recovery charge <sup>(‡)</sup>	Q <sub>rr</sub>		11.5		nC	

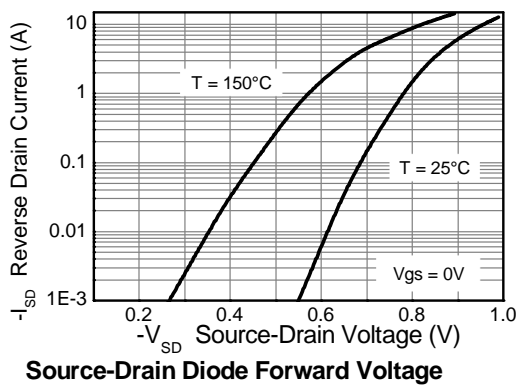
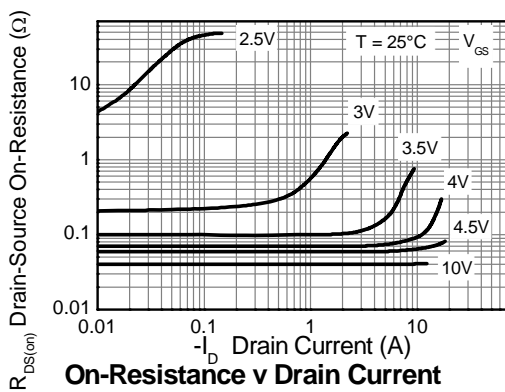
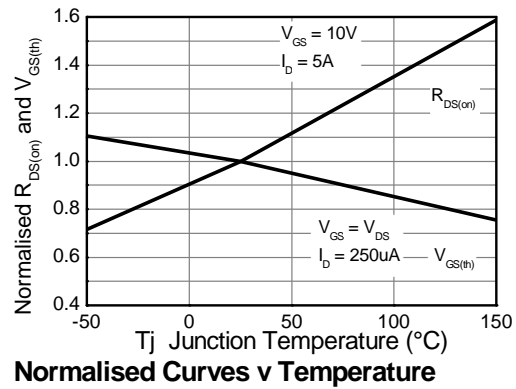
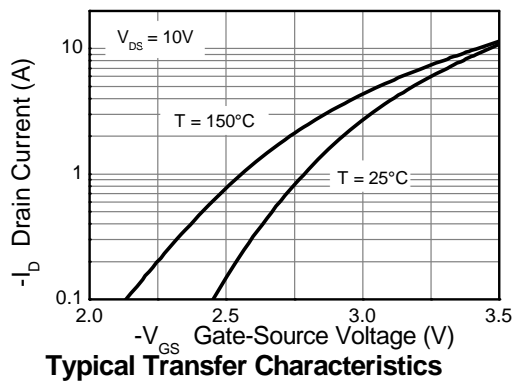
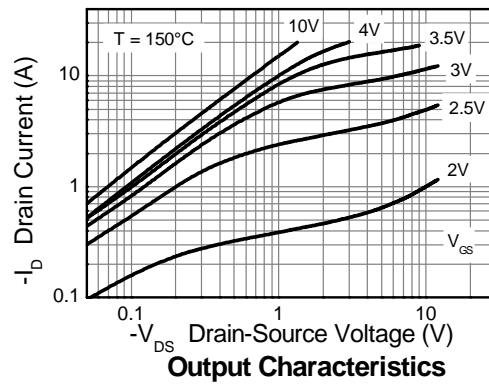
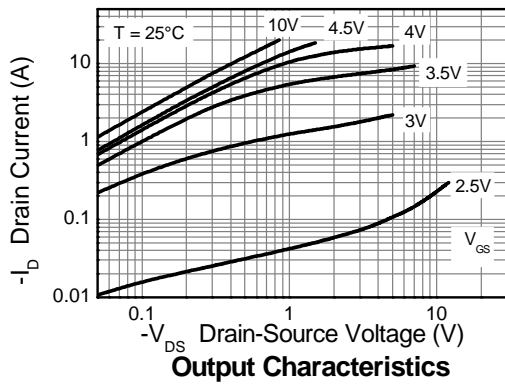
### NOTES:

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(†) Switching characteristics are independent of operating junction temperature.

(‡) For design aid only, not subject to production testing

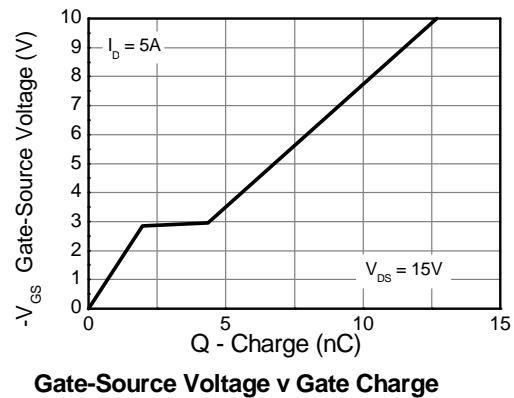
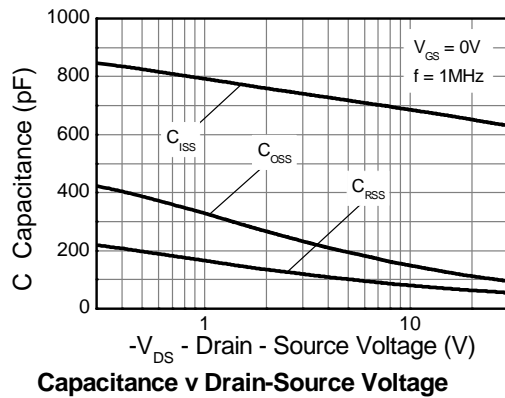
## Typical characteristics



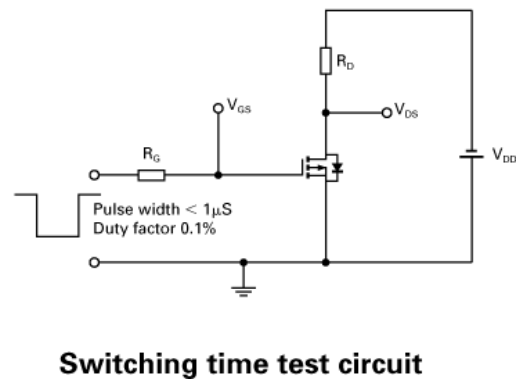
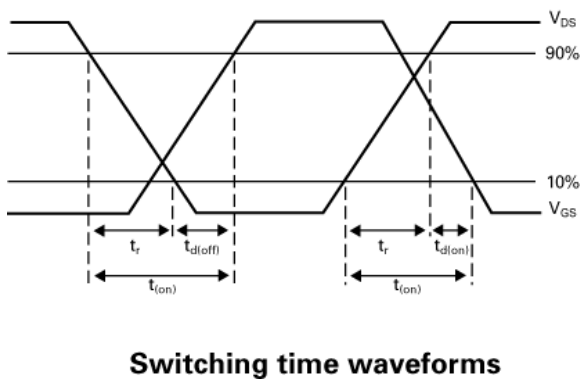
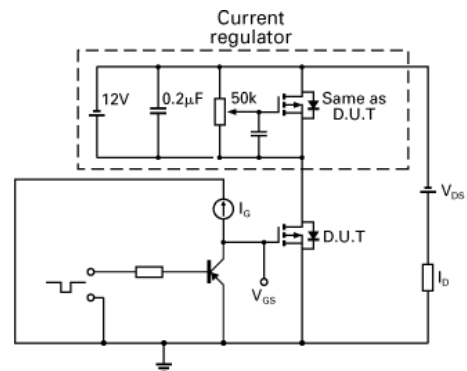
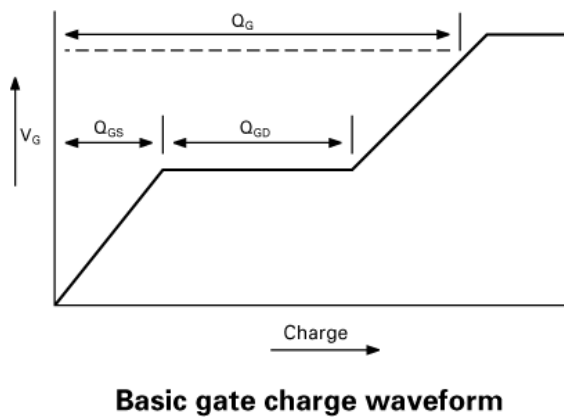


# ZXMC3F31DN8

## Typical characteristics

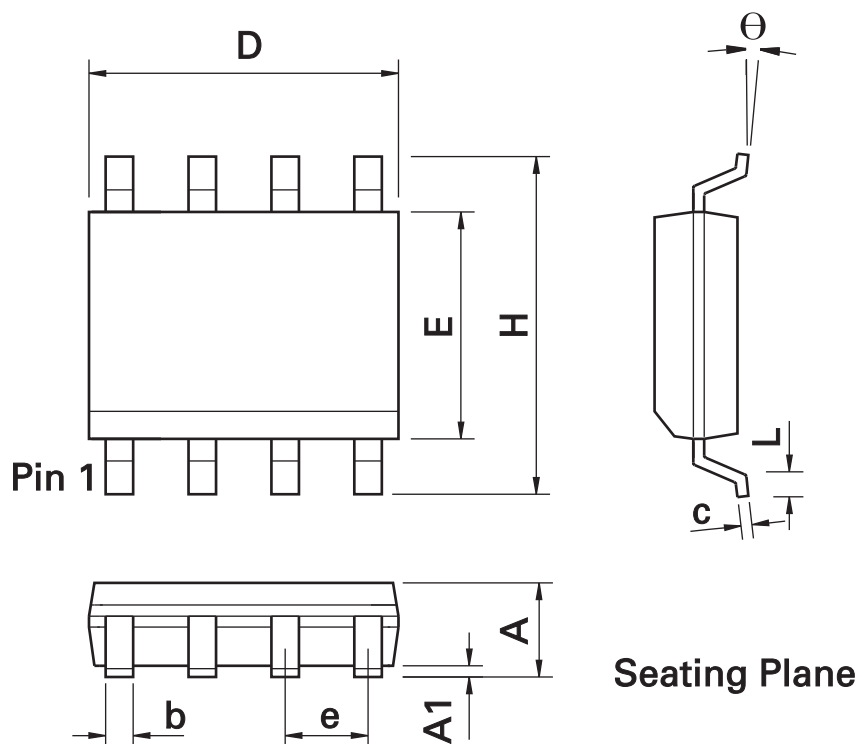


## Test circuits



# ZXMC3F31DN8

## Package outline SO8



## SO8 Package Information

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.053	0.069	1.35	1.75	e	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	c	0.008	0.010	0.19	0.25
H	0.228	0.244	5.80	6.20	U	0°	8°	0°	8°
E	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

**Note:** Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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"Active"	Product status recommended for new designs
"Last time buy (LTB)"	Device will be discontinued and last time buy period and delivery is in effect
"Not recommended for new designs"	Device is still in production to support existing designs and production
"Obsolete"	Production has been discontinued

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- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



#### Как с нами связаться

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